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Kingsville，Texas

TECHNICAL REPORT \＃2

COMPUTER PROGRAMS
AND DOCUMENTATION

# TEXAS A\&I UNIVERSITY 

## RESEAROH GRANT . 4 NGR 44-073-003

TECHNICAL REPORT \#2

COMPUTER PROGRAMS
AND DOCUMENTATION
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DEPARTMENT OF
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## 1. INTRODUCTION

This report contains a description of the various statistical tests that were used to check out random number generators. The tests contained in this report are by no means all the possible tests that can be run. A total of 12 different tests were considered. And from these, 6 were choosen to be used. Among those not included in this report are such tests as the poker test, the coupon test, the spectral test, and so on. The 6 tests that were choosen were done so because of the properties that they appeared to exhibit. Also, these are the most classical tests that are run. One test, which was not included, is the spectral test. The reason why It was not included was because of the need of a very large computer. If such a computer would have been available, we would have included this test because it is a very powerful test.

The tests included in this report are the frequency test, the $\max t$ test, the run test, the lag product test, the gap test, and the matrix test. This report is divided into three major sections. The first section concerns those tests of goodness of fit; and under this we have the frequency and the $\max t$ test. The next section consists of those tests of independence; and this includes the run, the lag product, the gap, and the matrix test. The final section gives documentation on the use of these various tegts as well as a listing of the programs.

The discussion in parts 2 and 3 makes the following assumptions. We have a sequence $U_{1}, U_{2}, U_{3}$, and so on that come from a pseudorandom number generator that is supposed to be generating random numbers from a uniform distribution and the numbers are supposed to be independently distributed. For the remainder of this report the terminology "random numbers" will be used to mean pseudorandom numbers.
2. GOODNESS OF FIT TESTS
A) Frequency Tests

The frequency test is one of the most popular tests used to check the uniformity of sequence of numbers. It consists in dividing the unit interval ( 0,1 ) into $k$ equal subintervals. Then a sequence of N pseudorandom numbers are generated. The number that fall in each of the subintervals is calculated and a chi-square test is applied. The chi-square test consisting of the observed number in each subinterval minus the expected number. The expected number in each interval is simply $N / K$. The distribution of the sum of the observed minus the expected squared divided by expected is approximately a chi-square with k-l degrees of freedom. It should be noted however that the expected number in each subinterval should be greater than five.
B) The Max T Test

In order to use the max t test, the following sequence is obtained:

$$
S_{j}=\max \left(U_{j 1}, U_{j 2}, \ldots, U_{j t}\right)
$$

It will be shown that $S_{j}$ has distribution function $F(s)=s^{t}$. Hence the Kolmogorov-Smirnov test can be used with $F(s)=s^{t}$. To see that $F(S)=s^{t}$, let us consider

$$
F(S)=P\left\{S_{j} \leq s\right\}=P\left\{\max \left(U_{j l}, \ldots, U_{j t}\right) \leq s\right\}
$$

since the maximum is less than or equal to S . Hence

$$
F(S)=P\left\{U_{j 1} \leqslant s, U_{j 2} \leqslant s, \ldots, U_{j t} \leqslant s\right\}
$$

$$
=\prod_{i=1}^{t} P\left\{U_{j 1} \leq s\right\} \text { since all } U_{j 1} \text { are independent. }
$$

But $P\left\{U_{j i} \leq s\right\}=s$, since $U_{j i} \sim U(0, l)$. Thus $F(S)=s^{t}$.

## 3. TESTS FOR INDEPENDENCE

## A) The Run Test

A sequence of numbers may be tested for runs up or may be tested for runs down by examining the length of monotone subsequences of the original sequence. That is, we investigate segements which are either increasing or decreasing. As an example of a run test, let us consider the following sequence $5,4,1,2,9,6,3,4,5,2,1,5,4$ in this sequence, we have 4 runs of length 1,1 of length 2 , and 2 of length 3. Note that contrary to the way most run test have been conducted, the chi-square test should not be applied to this data since the adjacent runs are not independent. Instead we shall use this data to construct a chi-square test that can be applied.

Let $A$ be a $6 \times 1$ vector such that $a_{i}=$ number of runs of length $1,1=1,2, \ldots, 5$ and $a_{6}=$ number of runs of length six or more. Let $B$ be a $6 \times 1$ vector such that $E\left(a_{1}\right)=$
$b_{1}$ and let $C$ be $6 x 6$ matrix such that $V(A)=C$, 1.e. $C$ is the covariance matrix of $A$. It has been shown in the "Annals of Mathematical Statistics" Vol. 15, p. 163-165, that A becomes normally distributed as the length of the original sequence tends to infinity. Thus $(A-B)^{T} C^{-1} A-B$ is approximately chi-square with 6 degrees of freedom. Expression for $B$ and $C$ are given in chapter 4.
B) Gap Test

This test is used to measure the lengths of $n$ gaps.
In this test, random numbers are generated until $n$ gaps occur. In this test we used a gap size of .1. (Note a gap size of .5 is equivalent to test of runs above or below the mean). Let $A$ be a txl vector such that

$$
a_{1}=\text { number of gaps of length } 1,1=1, \ldots, t-1
$$

$\bar{a}_{t}=$ number of gaps of length $t$ or greater.
Generate random numbers until $A_{i}=N G$, then $B$ is a txl vector of expected values; i.e. $b_{j}=N G \cdot P_{j}$ where $P_{j}=q(1-q)^{j-1}$ $j=1, \ldots, t-1 ; P_{t}=(1-q)^{t}$ and where $q=.1$. Hence $x^{2}=\sum_{j=1}^{t}\left(a_{j}-b_{j}\right)^{2} / b_{j}$,
which is chi-square with $t-1$ degrees of freedom. Note we must choose $N G$ and $t$ so that $b_{j} \geqslant 5$ for $j=1, \ldots, t$. The derivation of $P_{j}$ is as follows:

The probability of a gap of length 1 means that a number must be followed by itself. The probability that it occurs is just $q$. The probability of a gap of length 2 means we must have a
number followed by a different number and then followed by itself. Hence the probability that this happens is $(1-q) q$ etc.
C) The Lagged Product Test

This test is used to determine if there is a correlation between $U_{i}$ and $U_{i+k}$, where $k=1,2, \ldots$ In our test, $k=1, \ldots, 10$. The following statistic was computed:

$$
c_{k}=\frac{1}{N-k} \underset{i<1}{N} U_{i} \cdot U_{i+k}
$$

If $N$ is large and if there is no correlation between $U_{i}$ and $U_{i+k}$, then $C_{k}$ is approximately normally distributed with $E\left(C_{k}\right)=.25$ and $V\left[C_{k}\right]=(13 N-9 k) / 144(N-k)^{2}$. This can be seen from the following:

$$
E\left[C_{k}\right]=\frac{1}{N-k}{\underset{i}{幺}=1}_{N}^{N-k}\left(U_{i} \cdot U_{i+k}\right) .
$$

But $U_{i}$ and $U_{i+k}$ are assumed $\underset{N}{\text { uncorrelated }}$ with means equal to .5 . Hence $E\left(C_{k}\right)=\frac{1}{N-k} \quad i=1 \quad(.5)(.5)=.25$

$$
\begin{aligned}
V\left(C_{k}\right) & =\frac{1}{(N-k)^{2}} V \sum_{i=1}^{N} \sum_{i=1}^{-k} U_{i} U_{i+k} \\
& -\frac{1}{(N-k)^{2}} \sum_{i=1}^{N} \sum_{i=1}^{N} V\left(U_{i} U_{i+k}\right)+2 \sum_{i}^{N} \operatorname{Cov}\left(U_{i} U_{i+k}, U_{j} U_{j+k}\right.
\end{aligned}
$$

But $V\left[U_{1} U_{1+k}\right] \cdot E\left[U_{1} U_{1+k}\right]^{2}-\left(E\left(U_{1} U_{1+k}\right)\right)^{2}$
$=E\left[U_{i}^{2}\right] E\left[U_{i+k}\right]^{2}-(1 / 4)^{2}$
$=4 / 12 \cdot 4 / 12-1 / 16$
$=16 / 144-9 / 144=7 / 144$
$\operatorname{Cov}\left(U_{1} U_{1+k}, U_{j} U_{j+k}\right)=E\left[U_{1} U_{1+k} U_{j} U_{j+k}\right]-E\left(U_{i} U_{i+k}\right) E\left(U_{j} U_{j+k}\right)$
If $j \neq 1+k$, then $\operatorname{Cov}\left(U_{i} U_{i+k}, U_{j} U_{j+k}\right)=0$. If $j=1+k$, then

$$
\begin{aligned}
\operatorname{Cov}\left(U_{i} U_{1+k}, U_{j} U_{j+k}\right) & =E\left(U_{i+k}\right)^{2} 1 / 4-1 / 16 \\
& =4 / 12 \cdot 1 / 4-1 / 16=1 / 12-1 / 16 \\
& =3 / 144
\end{aligned}
$$

They are $N-2 k$ times that $1+k=j$. Hence

$$
\begin{aligned}
v\left[C_{k}\right] & =\frac{1}{(N-k)^{2}}[(N-k) \quad 7 / 144+(N-2 k) 6 / 144] \\
& =\frac{1}{(N-k)^{2} \cdot 144}[7 N-71+6 N-12 k] \\
& =\frac{1}{(N-k)^{2} \cdot 144} \quad[13 N-19 k]
\end{aligned}
$$

## D) Matrix Test

In order to investigate the degree of randomness between successive numbers in a sequence the matrix test was employed. This test was proposed by M. L. Tuncosa and suggests one construct $a k$ by $k$ matrix whose elements $x_{i j}$ represent the number of times a number in the $1^{\text {th }}$ interval is followed by a number in the $j^{\text {th }}$ interval. A sequence of $M$ consecutive sets of $N$ random numbers is generated, and equal values are expected for all the matrix elements. The chi-square statistic

$$
x^{2}=\sum_{1} \sum_{1} \sum_{j}^{k} \frac{\left(x_{1 j}-N / k^{2}\right)^{2}}{N / k^{2}}
$$

is computed and compared with expected chi-square distribution with $k^{2}-1$ degrees of freedom. A 90 per cent confidence interval was established as in the frequency test and is 948.1 and 1097.9. All generators with chi-square values in this range were considered acceptable.
4. SUBROUTINES

This section contains the subroutines used to carry out the tests. These were written in Fortran IV and run on the IBM $360 / 44$.
4.1 Goodness of Fit Tests
a) Frequency Test
b) Max T Test
4.2 Tests for Independence
a) Run Test
b) Gap Test
c) Lagged Product Test
d) Matrix Test

## SUBROUTINE FREQ

SOURCE:
Naylor, T. H., Balintfy, J. L., Burdick, D. S., and Chi Kong. Computer Simulation Techniques. New York: John Wiley and Son, Inc., 1966.

PURPOSE:
To check the uniformity of the distribution of the N random numbers.

CALLING SEQUENCE:
Random numbers between 0 and 1 are already generated and divided into $J$ groups before $F R E Q$ is called.

CALL FREQ (COUNT, J, N)
where:
$N$ is the number of random numbers
$J$ is the number of groups that the random numbers have been divided into.

COUNT is an array that contains the number of random numbers in each group.

METHOD:
The statistic $x^{2}$ is computed by:

$$
\chi^{2}=\sum_{I=1}^{J}(\operatorname{counT}(I)-E)^{2} / E
$$

where $E$ is the expected number of random numbers in each group. $x^{2}$ has approximately a chi-square distribution with $J$ - 1 degrees of freedom for a sequence of "truly" random numbers.

COMMENTS:
This subroutine calculates the upper and lower limits. $Z$ and w are the chi-square values at $90 \%$ confidence interval with $J-1$ degeees of freedom. The percent of the confidence interval may be changed, by changing $z$ and $w$ in the subroutine.

SUBROUTINE FREQ (COUNT,J,N)
DIMENSION COUNT(I)
C INI AND IN2 ARE LOGICAL DEVICE NUMBERS. TEXAS A+I
C USES 1 TO READ AND 3 TO WRITE FOR THE IBM $360 / 44$ COMPUTER.
$[\mathrm{Nl}=1$
IN2 $=3$
$E=F L O A T(N) / F L O A T(J)$
$C S=0$.
$004 \mathrm{I}=1$, J
CHI=( $(\operatorname{COUNT}(I)-E) * * 2) / E$
$4 \mathrm{CS}=\mathrm{CS}+\mathrm{CHI}$
WRITE(IN2.11) CS
11 FORMAT (1H,F15.6)
$W=-1.64$
$L=1.64$
$K=J-1$
$A=W * \operatorname{SQR} T(2 . * K)+K$
$B=Z$ \#SQRT(2.*K) +K
WRITE(IN2,10) K, A, B
10 FURMAT 1 IH, $10 X, 1901$ CONFIDENCE INTERVAL WITH K OEGREES OF FRFFOOM

IF (CS .GE. A .ANI). CS .LE. B) GO TO 22
WRITFIIN2.21)
GU TO 98
22 WRITEIIN2, 26)
21 FORMAT (IH, 'REJECT FRFQUENCY UISTRIHUTION")
26 FURMAT (IH. 'ACCEPT FREQUENCY DISTRIBUTION')
38 RETURN
END

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002160

SOURCE:
Knuth, Donald E., The Art of Computer Programming. AddisonWesley Publishing Company, Inc. 1969.

PURPOSE:
To determine if the random numbers come from a specified distribution.

CALLING SEQUENCE:
CALL KLOSMR (V,N,F,KN,D)
where:
$V$ is an array containing the $N$ random variables.
$N$ is the number of random variables.
$F$ is a function defined as $F(x)=x^{t}$, where $t$ is the
number of random numbers used to canpute each $V_{i}$.
$K N= \begin{cases}0 & \text { if } u=1, s=1 \\ 1 & \text { if } u-0, s \text { is calculated } \\ 2 & \text { if } u \text { and } s \text { are calculated }\end{cases}$
$D=\operatorname{MAX}\left|F(x)-S_{n}(x)\right|$ see method below

METHOD:
$N$ observations of the random quantity, $X$ are obtained.
The observations are rearranged so that they are sorted into ascending order, i.e., so that $X_{1} \leqslant X_{2} \leqslant \ldots \leqslant X_{n}$.

The following statistic is camputed:

$$
D=\operatorname{MAX}\left|F(x)-S_{n}(x)\right|
$$

where $F(x)$ - probability that $X \leq(x)$.

$$
S_{n}(x)=j / n, \quad X_{j} \leqslant x \leqslant X_{j+1}
$$

This value, $D$, is compared to a critical value in a table to determine if the data me from a specified distribution.

SUBROUTINE KOLSMR(X,N,F,KN,D) 00217
OIMENSION X(N),G(2000),JJl(200)

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002211
$00222!$
002231
002241
002251
002261
00227
002281
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$002350^{\circ}$
00230 C
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00261 C
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002640
002650
002600
00002670
00002680
0000269 C
00002700
FUNCTION F(X) ..... 002711
COMMON IT 002721$F=X *$ ITRE TURN002731002741END002751

```
    SUBROUTINE ORSEG( }x,y,N,J
    DIMENSION X(1), Y(1)
    DIMENSION J\1)
    IF(N.LE.20) GUTO }2
    IF(N.LE.130) GOTO 25
    NS=.014*FLUAT(N)+7.68
    INT=1
    NS1=NS-1
    00 10 I=1,NS
    IP=I-1
10 CALL OROER2(X,N,NS,IP)
    M=0
    J(1)=1
    00 11 1=2,NS
11J(1)=(I-1)*(N/NS)+1
    kl=2
    13 OO 13 I=K1,NS
    M1=J(I)
    M2 = J (I-1)
    IF(XIM1).LT.X(M2)) GOTO 12
    13 CONTINUE
    GOTO 14
    12 100 15 K=1,NS
    M3=J(K)
    IF(X(M1).LT.X(M3)) Guro 16
    15 CONTINUE
    16 CONTINUE
        I 1=1-1
        j) 17 KJ=k,11
        N1=K+11-KJ
        M4=J(Jl)
        J(Jl)=J(Jl+1)
    17 J(Jl+1)=M4
    Kl=I+1
    IF(KI.GT.NSS GOTO 14
    Goro 18
    14 M=M+1
    CHK2 =NS
        NP=J(INT)
        Y(M)=X(NP)
        IF(MOEQ.NI KETURN
        J(INT)=NP+1
        {F(J(INT).LE.(NS-1)*(N/NS)+1) GOTO 21
        IF(J(INT).LE.NI GOTU 20
    22 INT=INT+I
        GOTO 20
    21 IF(MOD((J(INT)-1),N/NS).EQ.OI INT=[NT+1
    20 Jl=J(INT)
        13= INT+1
        IF(I3.GT.NSI GUTO 14
        OO 19 KQ=13,NS
        CHK3=NS
        J2=J(KQ)
        IF(X(J1).LT.X(J2)) GOTO 14
        J(KQ)=J(KQ-1)
        J(KQ-1)=J2
    19 CONTINUE
        Guro }1
    23 CALL ORDER2(X,N,I,O)
23 CALL ORDER2( \(x, N, 1,0)\)
```

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15

|  | $0024 \mathrm{l}=1, \mathrm{~N}$ | 000600 |
| :---: | :---: | :---: |
| 24 | Y(I) $=\mathrm{X}(\mathrm{I})$ | 000610 |
|  | RETURN | 000620 |
| 25 | CALL ORSEG3( $\mathrm{X}, \mathrm{Y}, \mathrm{N}$ ) | 000630 |
|  | RETURV | 000640 |
|  | END | 000650 |

```
    SUBROUTINE ORSEG3(X,Y,N)
    DIMENSION X(1), Y(1)
    N3=N/3
    DO 10 K=1,3
    IP=K-1
    10 CALL ORDER2(X,N,3,IP)
    M=0
    I=1
    J=N3+1
    K=2*(N/3)+1
    IF(X(I).LT.X(J)) GOTO 14
    NS=1
    I=J
    J=NS
    14 IF(X(J).LT.X(K)) GOTO 13
    LF(X(K).GT.X(I)) GUTO 15
    NS=1
        I=K
        K=NS
    15 NS=J
        J=K
        K=NS
    13 M=M+1
    Y(M)=X(I)
    IFIM.FQ.NI RETURN
    IF(I.EQ.NI GOTO 1O
    I=I+I
    IF(X(I).LT.X(I-1)) Goro 16
    IF(X(I).LT.X(J)) GOTO 13
    NS=I
    I=J
    J=NS
    IF(X(J).LT.X(K)) GUTO 13
    GOTO 15
    16 M=M+1
        Y(M)=X(J)
        IF(M.EQ.N) RETURN
        J=J+1
        IF(X(J).LT.X(J-I)) GOTO 18
        IF(X(J).LT.X(K)) GOTO 16
    17-M=M+1
    Y(M)=X(K)
    IF(M.EQ.N) RETURN
    K=K+1
    IF(X(K).LT.X(K-1)) Goro 20
    IF(X(K).LT.X(J)) GOTO 17
    GOTO 16
    K=J
    18 Ml=M+1
    OU 19 MS=M1,N
        Y(MS) = X(K)
    14 K=K+1
        RETURN
        END
```

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001390
001400
001410
001420

```
            SUBROUTINE ORDER2(X,N,LL,L2)
    DIMENSIUN X(1)
        N2=L2*(N/L1)+1
        NN=(L2+1)*(N/L1)
        IF(L2.EQ.LI-1) NN=N
        Kl=N2+1
    4 00 99 I=K1,NN
        IF(X(I).LT.X(I-1)) GOTO 76
99 CONTINUE
    RETURN
76 DO 82 K=N2,NN
    IF(X(I).LT.X(K)) GO TO 84
82 CONTINUE
84 L=X(I)
    I 1=1-1
    DO 86KJ=K,I1
    J=K+II-KJ
86 X(J+1)=X(J)
    x(K)=2
    Kl=I +1
        IFIKI.GT.NNI RETURN
        GOTO }
        END
99 CONTINUE
RETURN
76 DO \(82 \mathrm{~K}=\mathrm{N} 2\), NN
IF(X(I).LT.X(K)) GO TO 84
32 CONT INUE
\(84 \mathrm{Z}=\mathrm{XI}\) (I)
\(11=1-1\)
DO \(86 K J=K, I 1\)
\(J=K+I 1-K J\)
\(86 \times(J+1)=X(J)\)
\(x(K)=2\)
\(K 1=I+1\)
IFIKI.GT.NNI RETURN
GOTO 4
END
```

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## MAX "T" TEST

N random variables are generated where each random variable, $V_{1}$, is defined as:

$$
v_{1}=\operatorname{MAX}\left(R_{11}, R_{21}, \ldots, R_{t 1}\right)
$$

Each $R_{j 1}$ is a random number, where $j=0,1,2, \ldots, t$, and $t$ is the number of random numbers.

The Kolmogorov - Smirnov test is applied to the sequence $V_{0}, V_{1}, \ldots, V_{n}-1$, with the distribution function $F(x)=x^{t}, \quad(0 \leq x \leq 1)$.

SUBROUTINE RUN

SOURCE:
Knuth, Donald E., The Art of Computer Programming. AddisonWesley Publishing Company, Inc. 1969.

PURPOSE:
To determine if the length of runs come from "true" random numbers.

CALLING SEQUENCE:
N random numbers between 0 and 1 have been generated before RUN is called.

CALL $\operatorname{RUN}(N, R, A)$
where:
$N$ is the number of random numbers.
$R$ is an array containing the random numbers.
A is an array containing the coefficients used to compute the statistic $V$.

## METHOD:

The length of runs are determined. The length of a run is the number of consecutive increasing numbers inclusively. Any run longer than $s i x(6)$ is counted as a run of 6 .

The statistic $V$ is then computed by:
$V=\frac{1}{N} \sum_{I}^{6} \sum_{J=1}^{6}(\operatorname{COUNT}(I)-N * B(I)) *(\operatorname{CoUNT}(J)-N * B(J) * A(I, J))$
where the coefficients $A(I, J)$ and $B(J)$ are:

| $\left[{ }^{a_{11}} \mathrm{a}_{12} \mathrm{a}_{13} \mathrm{a}_{14} \mathrm{a}_{15}{ }^{a_{16}}\right.$ |  | [4529.4 | 9044.9 | 13568 | 18091 | 22615 | 27892 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $a_{21} a_{22} a_{23} a_{24} a_{25}{ }^{a_{26}}$ |  | 9044.9 | 18097 | 27139 | 36187 | 45234 | 55789 |
| $a_{31} a_{32} a_{33} a_{34} a_{35}{ }^{\text {a }} 36$ |  | 13568 | 27139 | 40721 | 54281 | 67852 | 83685 |
| $a_{41} a_{42} a_{43} a_{44} a_{45} a_{4}$ |  | 18091 | 36187 | 54281 | 72414 | 90470 | 111580 |
| $a_{51} a_{52} a_{53} a_{54} a_{55} a_{56}$ |  | 22615 | 45234 | 67852 | 90470 | 113262 | 139476 |
| $a_{61} a_{62} \quad a_{63} \quad a_{64} a_{65} a_{66}$ |  | 27892 | 55789 | 83685 | 111580 | 139476 | 172860 |

$$
\left(b_{1} b_{2} b_{3} b_{4} b_{5} b_{6}\right)=\left(\frac{1}{6} \frac{5}{24} \frac{11}{120} \frac{19}{720} \frac{29}{5040} \frac{1}{840}\right)
$$

V should have the ch1-square distribution with six degrees of freedom.

COMMENT:
The upper and lower limits for a $90 \%$ confidence interval have been put into the subroutine. $V$ is then checked to see if it falls between these limits. The percent of confidence interval may be changed by changing the limits in the subroutine.

SUBROUTINE RUN (N,T,A)
INTEGER COUNT(20)
OIMENSION T(1),B(6),A(6,6)
C INI AND IN2 ARE LOGICAL DEVICE NUMBERS. TEXAS atI
C. USES 1 TO READ ANO 3 TO WRITE FOR THE IBM $360 / 44$ COMPUTER.

INI=1
IN $2=3$
I $\Delta=6$
OU $2[=1, I A$
2 COUNT(I)=0
$T(N)=0.0$
$\mathrm{R}=1$
$10018 \mathrm{~J}=1, \mathrm{~N}$
IF(T(J) .GT. T(J+1)) GOTO 22
$R=R+1$
18 CUNTINUE
22 [F (R.GE. IA) GO TO 24
$23 \operatorname{CUUNT}(R)=\operatorname{COUNT}(R)+1$
GO TO 25
74 COUNTIIA) $=\operatorname{COUNT}(I A)+1$
$25 R=1$
IF(J •LT• (N-1) G GU TO l8
WRITEIIN2,16) (COUNT(II,I=1,6)
16 FORMAT(1H,5X, 'RUN',618)
$W=1.64$
$z=12.6$
$B(1)=(1.16 .1$
$B(2)=(5.124$.
$\mathrm{H}(3)=(11 . / 120$.
$B(4)=(19.1720 .1$
$B(5)=(29.1504()$.
$3(6)=(1.1840 .1$
$v=0$.
DO $44 \quad \mathrm{I}=1$, IA
DU $44 \mathrm{~J}=1,1 \mathrm{IA}$
$44 V=V+(\operatorname{COUNT}(I)-N * B(I)) *(C O U N T(J)-N * B(J)!* A(I, J)$
$V=V / N$
IFIV .LE. Z .AND. V .GE. WI GO TC 55
WRITE(IN2.65) V
65 FURMAT(1H,.5X, 'V =, E17.7. 5X,'REJECT RUN' I
GO TO 77
55 WRITE(IN2,66) V
OS FJRMAT(1H, 5X.'V =', ELT.7,5X,'ACCFPT RUN')
17 RETURN
END

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## SUBROUTINE GAPT

## SOURCE:

Knuth, Donald E., The Art of Computer Programming. AddisonWesley Publishing Company, Inc. 1969.

## PURPOSE:

To check if the length of $N G$ gaps are distributed as expected in "true" random numbers.

CALLING SEQUENCE:
Random numbers between 0 and 1 are generated before GAPT is called.

CALL GAPT ( $\mathrm{N}, \mathrm{JG}, \mathrm{R}, \mathrm{NG}$ )
where:
N is the number of random numbers generated.
$J G$ is the length of the longest gap being counted.
$R$ is the array containing the random numbers.
NG is the number of gaps that are counted.

METHOD:
The first random number is compared with the following random numbers until it is found to be equal to one of the following random numbers. A gap is of length $L$, where $L$ is the number of random numbers between those two equal random numbers. The next random number is used to compare with the following random numbers. The process is continued until NG gaps have been found.

$$
\begin{aligned}
& E P(0)=P(N G), \quad E P(I)=\sum_{I=1}^{J G}-1 \\
& E P(I-P)^{I}, \\
& E P(J)=N G(P)(1-P)^{J G} . \\
& E P(I) \text { is the expected number of gaps for a gap length } \\
& \text { of } I .
\end{aligned}
$$

The $x^{2}$ statistic is then computed by:

$$
x^{2}=\sum_{I=1}^{J G}[\operatorname{GAP}(I)-\operatorname{EP}(I)]^{2} / E P(I) .
$$

$x^{2}$ has approximately a chi-square distribution with JG degrees of freedom for "truly" random numbers.

## COMMENTS:

The upper and lower limits for a $90 \%$ confidence interval have been put into the subroutine. $x^{2}$ is then checked to see if it falls between these limits. The percent of confidence interval may be changed by changing the limits in the subroutine.

## SUBROUTINE GAPT (N,JG,R,NG)

C THIS IS THE GAP TEST.
C A GAP OF LENGTH K IS DBTAINED WHEN THERE ARE K DIGITS BETWEEN TWO
C DIGITS WHICH ARE IDENTICAL.
C $\operatorname{N}$ IS THE NUMBEF OF RANOOM NUMBERS GENERATEO FOR THIS TEST.
C JG IS THE LENGTH OF THE LUNGEST GAP BEING RUN.
C ANY GAP LONGER THAN JG IS BEING COUNTED AS A GAP OF LENGTH JG.
$C$ VG IS THE NUMBER OF GAPS.
DIMENSIUN R(1),GAP(100), EP (100)
$C$ INI AND IN2 ARE LOGICAL DEVICE NUMBERS. TEXAS A+I
C USES 1 TO READ AND 3 TO WRITE FOR THE IBM $360 / 44$ COMPUTER.
IN1=1
IN2=3
I $S=0$
GAPU=0
DO $5 \mathrm{I}=1, \mathrm{JG}$
$5 G A P(I)=0$
$K=R(1) * 10+1$
$L=0$
$J=$ ?
$19 \mathrm{~L}=0$
DU $6 \quad I=J, N$
$M=R(I) * 10+1$
1F(M.FQ.K) GUTO11
$L=L+1$
IF(L.EO.JG) GOTOII
GU TO 6
$11 \mathrm{~J}=\mathrm{I}+2$
$K=R(I+1) * 10+1$
IF (L.GE.JG) GO TO 17
IFIL -NE. O) GO TD 12
$G A P C=G A P O+1$
GO TU 18
$12 G A P(L)=G A P(L)+1$
GO TO 18
17 GAP $(J G)=G A P(J G)+1$
$1 甘 \quad I S=I S+1$
IF(IS •EQ. NG) GO TU 22
GO TC 19
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- GONTI NUE

000830
WRITE(IN2,13) IS
000840
000850
13 FORMAT (1H, 'NOT ENOUGH KANDUM NUMBERS', $10 X$, IS $=$. 151
000860 .
GO TO 88
000870
$22 \mathrm{P}=.1$
WRITE(IN2,211) GAPO
211 FORMAT(1H, GAPO $=$ ', F4.1)
WRITE(IN2,213) (GAP(I),I=1,19)
213 FORMAT(1H, 'GAP $=0.10 \mathrm{FB} .1)$
$E P O=P * N G$
$K=J G-1$
OO $27 L=1, K$
27 FP(L)=NG*P*((1-P)**L)
$E P(J G)=N G *((1-P) * * J G)$
$C S=(G A P O-E P O) * * 2 / E P O$
Dก 77 I = 1, JG
$77 C S=C S+(G A P(I)-E P(I)) * * 2 / E P(I)$
$K=J G$
$A=18.3$
$B=3.94$
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001000
001010
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001030
IFICS.GE.B.AND. CS.LE.AI GO TO 26001040WRITE(IN2,51) K,A,B,CSGO TU 88
26 WRITE(IN2.52) K,A,B,CS001050
51 FORMAT (1H.'901 CONF. INT. WITHK DEG. OF FREEDUIA., 5X. ${ }^{\circ} \mathrm{K}={ }^{\circ}, 13.5 \mathrm{X}$.001060$1^{\prime} A=1, F 7.2 .5 X,{ }^{\prime} B=1, F 7.2 .5 X,{ }^{\circ} \mathrm{C} S=1, F 10.2 .5 X,{ }^{\prime}$, REJECT GAP TEST'।
52. FGRMATIIH, '90( CONF. INT. WITH K DEG. OF FREEDOM',5X, ${ }^{\circ} \mathrm{K}={ }^{\circ}$, I 3 , 5 X ,$2^{\circ} A={ }^{\prime}, F 7.2,5 X,{ }^{\prime} B={ }^{\prime}, F 7.2,5 X,{ }^{\prime} C S={ }^{\circ}, F 10.2,5 X,{ }^{\prime} A C C E P T$ GAP TEST'I88 RETURNEND001070COLO 0001090

## SUBROUTINE LPTEST

SOURCE:
Naylor, T. H., Balintfy, J. L., Burdick, D. S., and Chu Kong. Computer Simulation Techniques. New York: John Wiley and Son, Inc., 1966.

PURPOSE:
To check if there is a correlation between $r_{1}$ and $r_{i}+k$ random numbers.

CALLING SEQUENCE:
Random numbers between 0 and 1 are generated before LPTEST is called.

CALL LATEST (NoR)
where:
$N$ is the number of random numbers.
$R$ is the array of random numbers.

METHOD:
The lagged product coefficient, $C_{k}$, is computed for each $K$. where $K$ is the length of the lag.

$$
c_{k}=\frac{1}{N-K} \quad \sum_{i}^{N-1} r_{1}^{-K} r_{i}+k
$$

If there is no correlation between $r_{i}$ and $r_{1}+k$, the value of $C_{k}$ will be approximately normally distributed with expected value of 0.25 .

Lower and upper limits are computed for $90 \%$ confidence interval and each $C_{k}$ is checked to see if it falls between these limits. Standard deviation is equal to $\sqrt{13 \mathrm{~N}-19 \mathrm{~K} / 12}(\mathrm{~N}-\mathrm{K})$.

COMMENTS:
The $90 \%$ confidence interval can be changed, by changing the value of $z$ in the subroutine. $z$ and $-z$ are the values for $90 \%$ confidence interval of normal distribution. The value of $K$ cannot be larger than $N$.

```
    SUBROUTINE LPTEST (N,R)
    DIMENSION R(1)
    -C INI AND IN2 ARE LOGICAL DEVICE NUMBERS. TEXAS A+I
    C USES 1 TO PFAD AND 3 TO WRITE FOR THF IBM 360/44 COMPUTER.
            |N1=1
            IN2=3
            DO 99 K=1.15
            C=0.
            M=N-K
            DO 2 I = 1,M
        2C=C+R(I)*R(I+K)
            CK=C/M
            WRITEIIN2,100) K,CK
        100 FORMAT (1H,'K=',12,10X,'CK =',F10.51
        L=1.64
        SD=SQRT(13.*N-19.*K)/(12.*M)
        B=0.25+2*SO
        A=0.25-2*SD
        WRITEIIN2.103) A,B
        IF ICK.GE. A .AND. CK .LE. BI GO TO 40
        WRITE(IN2,102)
        GU TO Y9
        40 WRITE(IN2.101)
    IO1 FORMAT (IH 'ACCEPT THE LAGGED PRODUCT TEST'I
    LC2 FORMAT (1H, 'REJECT THE LAGGED PROOUCT TEST')
        103 FORMAT(1H, 'A =', F10.5.10X,'B=',F10.51
        99 CONTINUE
        98 RETURN
        END
```

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## SUBROUTINE MATRIX

SOURCE:
Naylor, T. H., Balintfy, J. L., Burdick, D. S., and Chu Kong. Computer Simulation Techniques. New York: John Wiley and Son, Inc., 1966.

## PURPOSE:

To determine if successive numbers are "truly" random.

CALLING SEQUENCE:
N random numbers between 0 and 1 are generated before MATRIX is called.

CALL Matrix (N,R,L)
where:
N is the number of random numbers
$R$ is the array containing the random numbers
$L$ indicates that the size of the matrix is LxL.

## METHOD:

The interval of 0 to 1 is divided into $L$ subintervals. Successive random numbers are paired off and placed into an LxL matrix according to the random numbers of that pair. The $x^{2}$ statistic is then computed as follows:

$$
x^{2}=\sum_{1} \sum_{1}^{L} \sum_{j=1}^{L}\left(f_{1 j}-E\right)^{2} / E
$$

where $f_{i j}$ is the number of pairs of random numbers in each element of the matrix and $E$ is the expected number of pairs of random numbers in each element of the matrix. $x^{2}$ has approximately a chi-square distribution with $L$ L -1 degrees of freedom for "truly" random numbers.

COMMENT:
This subroutine calculates the upper and lower limits for the numbers to be accepted as "truly" random. $Z$ and $W$ are the chi-square values at $90 \%$ confidence interval with L L - 1 degrees of freedom. The percent of confidence interval may be changed, by changing $Z$ and $W$ in the subroutine.

```
        SUBROUTINE MATRIX(N,R,L)
        OIMENSION MTRX(32,32), R(1)
C INI ANO IN2 ARE LOGICAL DEVICE NUMBERS. TEXAS A +I
C USES 1 TO READ AND 3 TO WRITE FOR THE IBM 360/44 COMPUTER.
INl=1
        IN2=3
    C THE MATRIX IS SET TO zERO.
        DO 22 I=1,L
DO 22 J=1,L
        22 MTRX(I,J)=0
    C RANDOM NUMBERS ARE PAIRED UFF AND A COUNTER IS INCREMENTED
C ACCORDING TO WHERE THE RANDOM PAIR FIT IN THE MATRIX.
            DO 11 I= l,N,2
        KM=L*R(I) +1
        LM=L*R(I + I) +l
        11 MTRX(KM,LM)=MTRX(KM,LM)+1
    C E IS THE EXPECTED NUMBER OF PAIR JF RANDOM NUMBERS TO BE
    C FOUND IN EAC.H ELEMENT OF THF MATRIX.
        I=FLCAT (N)/2.
        E=U/(FLOAT(L)*FLOAT(L))
    C THE CS STATISTIC HAS A CHI-SQUARE DISTRIHUTIUN WITH
    C L*L-1 DFGREES OF FREEDOM.
        CS=0.
        DO 12 I= 1.L
            10 12 J=1,L
        12CS=CS+(MTRX(I,J)-E)**2/E
            Z=1.64
            w}=-
            K=L*L-1
            AK=K
    C A IS THF LOWER AND S IS THE UPPER LIMIT FOR THIS TEST TU BE ACCEPTED.
        A=W*SURT(2.*AK) +AK
        B=2*S QRT(2.*AK) + AK
        WRITE(IN2,44) K,A,B,CS
        IF(CS.GE.A .AND.CS .LE. ©) GO TO 28
        WRITE(IN2,38)
        GU TO 88
        28 WRITEIIN2.391
        4 4 \text { FUKMATIIH, IOX, 'qO\ CONFIDENCE INTERVAL WITH K DEGREES IFF FREEDOM'}
```



```
        38 FORMAT(1H , 20X,'REJECT MATRIXTEST')
    39 FURMAT(1H ,5X, 'ACCEPT MATRIX TEST')
    BB RETURN
        END
            000010
        000020
000030
000040
000050
        000380
        00390
```



```
000400
000410
00420
000440
```

